


<b>Search Notes</b> 	<b>Application/Control No.</b> 10595636	<b>Applicant(s)/Patent Under Reexamination</b> OKAZAWA ET AL.
	<b>Examiner</b> Tianjie Chen	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
720	741		
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	738	07/17/2008	TJ

SEARCH NOTES			
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